

BOSA series 6

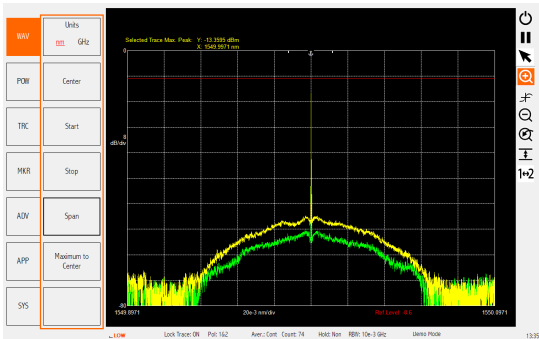
BOSA is the **most advanced and versatile High Resolution Optical Spectrum Analyzer in the market**. Thanks to our unique optical filtering and full spurious free dynamic range the BOSA achieves reliable measurements avoiding artifacts and undesired effects on your measurements.

BOSA's unique combination of high-resolution and high dynamic-range brings a new range of measurement possibilities to the optical domain. BOSA reveals the **optical spectra of the signals with a detail and precision** that enables direct measurement of performance parameters for lasers and modulated signals



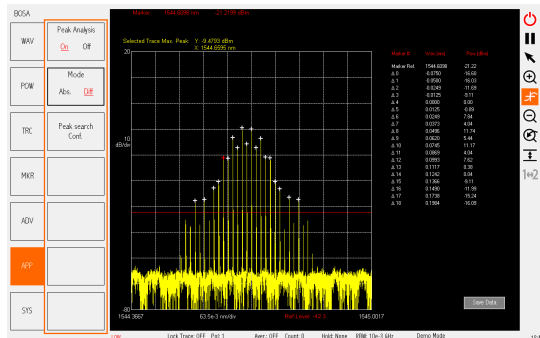
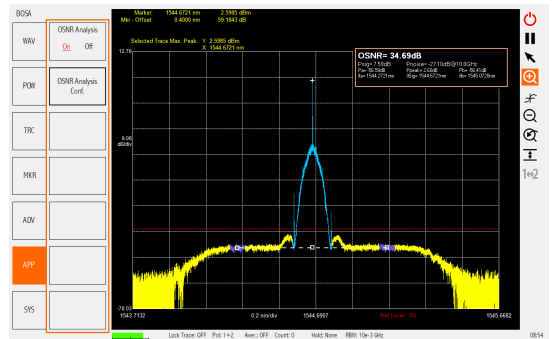
KEY FEATURES

- ✓ **High resolution** (10 MHz / 0.08 pm) and purely optical narrow filter
- ✓ Great dynamic range (>80 dB) with no artifacts. **Maximum reliability**
- ✓ Unique spectrally-resolved polarization measurement
- ✓ Patented optical **phase spectrum measurement**: chirp measurement, eye diagram, constellation...
- ✓ Integrated tunable laser and component analyzer for **maximum versatility**



TECHNOLOGY

BOSA **all-optical patented technology** use the stimulated Brillouin scattering (SBS) as a non-linear optical effect that causes a very **narrow filtering** effect. By pumping the SBS with an external cavity tunable laser source (TLS), the filter is swept along the spectral region of interest, giving the high-resolution optical spectrum. The threshold imposed by SBS eliminates all the spurious effects of the local oscillator sidemodes that produce measurement artifacts in heterodyne OSAs, giving the highest **spurious-free** dynamic range measurement available in any HR-OSA.



APPLICATIONS

- Pulsed lasers & frequency combs
- 100G/400G transceiver testing
- Advanced modulation formats: OFDM, Nyquist, 4PAM, QAM, DP-QPSK...
- Chirp effects analysis
- Non-linear laser dynamics

High-Resolution Optical Spectrum Analyzer

TECHNICAL SPECIFICATIONS

Optical	
Wavelength range	C band: 1525-1565 nm C+L bands: 1525-1610 nm O band: 1265-1345 nm S & T bands available on request
Optical resolution (FWHM)	10 MHz
Calibrated power range	+13 to -70 dBm
Maximum safe total input power	+20 dBm
Sweep time	20 nm/s
Wavelength reference	Linearization + absolute reference
Measurement	
Spurious-free dynamic range	>80 dB
Sensitivity (@10 MHz)	-70 dBm
Power accuracy	±0.5 dB
Wavelength accuracy	±0.5 pm (C, C+L) ±1.0 pm (O)

OTHER SPECIFICATION

Physical & electrical	
Operating Temperature	+15 °C to +35 °C
Power Requirements	110/220V; 50/60Hz Máx. 200W.
Dimension & Mass	430x230x470 (mm). Máx. 18Kg
Optical Connections	FC/APC Others on request
Available interfaces	Ethernet, USB, GPIB

TECHNICAL SPECIFICATIONS

	BOSA Options		
Measured bands	C band	C+L band	O band
Option 10 - Tunable laser output			
Wavelength Range	1516-1565 nm ^a	1521-1630 nm ^b	1265-1345 nm
Absolute accuracy	±1.5 pm	±2.0 pm	
Tuning speed	1-100 nm/s ^c		
Output power	>1 mW		
Side-mode suppression	>43 dB	>45 dB	
RIN	<-145 dB/Hz	<-140 dB/Hz	
Linewidth	<1 MHz ^d		
Trigger output	BNC		
Option 20 - Component analyzer			
Wavelength range	1516-1565 nm ^a	1521-1630 nm ^b	1265-1345 nm
Wavelength accuracy	±1.0 pm	±2.0 pm	
Power accuracy	±0.2 dB		
Polarization Measurement	Two orthogonal states. PDL with option 30		
Output power	>0 dBm		
Sensitivity	-70 dBm (IL) -45 dBm (RL)		
Calibrated input range	-10 to -70 dBm		
Spurious-free dynamic range	>80 dB ^e		
Measurement time	1 s for 100 nm ^f		
Option 30 - Spectral polarimetry			
Polarization repeatability	±5°		
Temperature dependence	±0.2°/°C		
Measurement time	6 scans at 20 nm/s ^g		
Polarization sensitivity	-40 dBm		
Polarization crosstalk	<20 dB		
Option 40 - Phase measurement			
Wavelength range	1525-1565 nm ^a	1525-1615 nm ^b	1265-1345 nm
Bandwidth	80 MHz to full span		
Pattern Frequency Range	70 MHz to 2 GHz		
Phase accuracy	±1°		
Sensitivity	-70 dBm		
Electrical Reference input power	+5 to -15 dBm		
Measurement time	1 s for 20 nm ^f		